## Applicant(s)/Patent Under Application/Control No. Reexamination 10/823,499 **GRUNDY ET AL.** Notice of References Cited Art Unit Examiner Page 1 of 1 2186 Pierre-Michel Bataille **U.S. PATENT DOCUMENTS** Document Number Date Name Classification MM-YYYY Country Code-Number-Kind Code 06-2002 Greeff et al. 710/305 Α US-2002/0083255 06-2002 В US-2002/0067915 Shida et al. 386/111 С US-US-D US-Ε F US-G US-Н US-US-

## **FOREIGN PATENT DOCUMENTS**

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